

# IGC03R60DE

TRENCHSTOP<sup>™</sup> RC-Series for hard switching applications

## IGBT chip with monolithically integrated diode in packages offering space saving advantage

## Features:

TRENCHSTOP<sup>™</sup> Reverse Conducting (RC) technology for 600V applications offering:

- $\bullet$  Optimised  $V_{CEsat}$  and  $V_{F}$  for low conduction losses
- Smooth switching performance leading to low EMI levels
- Very tight parameter distribution
- Operating range of 1 to 20kHz
- Maximum junction temperature 175°C
- Short circuit capability of 5µs
- Best in class current versus package size performance
- Qualified according to JEDEC for target applications
- Complete product spectrum and PSpice Models: http://www.infineon.com/igbt/

### **Applications:**

#### Used for:

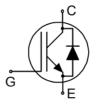
Motor drives

Discrete components and molded modules

| Chip Type  | V <sub>CE</sub> | I <sub>Cn</sub> | Die Size                   | Package      |
|------------|-----------------|-----------------|----------------------------|--------------|
| IGC03R60DE | 600V            | 2.5A            | 1.6 x 1.73 mm <sup>2</sup> | sawn on foil |

### **Mechanical Parameters**

| Mechanical Paramet           | ers                              |   | 1  |  |  |
|------------------------------|----------------------------------|---|----|--|--|
| Raster size                  |                                  | 1.6 x 1.73  |    |  |  |
| Emitter pad size             |                                  | see chip drawing  |    |  |  |
| Gate pad size                |                                  | see chip drawing  |    |  |  |
| Area: total / active IGE     | BT / active Diode                | 2.768 / 1.192 / 0.222   |    |  |  |
| Thickness                    |                                  | 70  | μm |  |  |
| Wafer size                   |                                  | 200   | mm |  |  |
| Max.possible chips per wafer |                                  | 10182   |    |  |  |
| Passivation frontside        |                                  | Photoimide  |    |  |  |
| Pad metal                    |                                  | 3200 nm AlSiCu  |    |  |  |
| Backside metal               |                                  | Ni Ag –system   |    |  |  |
| Die bond                     |                                  | Electrically conductive epoxy glue and soft solder (temperature budget: 290°C for 1min. or 260°C for 1.5min.)   |    |  |  |
| Wire bond                    |                                  | Al, <250µm  |    |  |  |
| Reject ink dot size          |                                  | Ø 0.65mm ; max 1.2mm  |    |  |  |
| Storage environment          | for original and sealed MBB bags | Ambient atmosphere air, Temperature 17°C – 25°C,<br>< 6 month   |    |  |  |
|                              | for open MBB bags                | Acc. to IEC62258-3: Atmosphere >99% Nitrogen or inert ga<br>Humidity <25%RH, Temperature 17°C – 25°C, < 6 month |    |  |  |





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## **Maximum Ratings**

| Parameter  | Symbol  | Value   | Unit |
|--|---|---------|------|
| Collector-Emitter voltage, <i>T</i> <sub>vj</sub> =25 °C                                     | V <sub>CE</sub>   | 600     | V    |
| DC collector current, limited by $T_{vj max}$  | I <sub>C</sub>  | 1)      | А    |
| Pulsed collector current, $t_p$ limited by $T_{vj max}$                                      | I <sub>c,puls</sub>   | 7.5     | А    |
| Gate emitter voltage   | V <sub>GE</sub>   | ±20     | V    |
| Junction temperature range   | T <sub>vj,max</sub>   | -40+175 | °C   |
| Operating junction temperature   | T <sub>vj,op,max</sub>  | -40+175 | °C   |
| Short circuit data $^{2}$ $^{3)}$ $V_{GE} = 15V$ , $V_{CC} = 400V$ , $T_{vj} = 150^{\circ}C$ | t <sub>SC</sub>   | 5       | μs   |
| Safe operating area IGBT <sup>2 )3)</sup>  | $I_{C,max} = 5A, V_{CE,max} = 600V, T_{vj,op} \le T_{vj,op,ma}$                                 |         |      |
| Safe operating area Diode <sup>2</sup> )   | $I_{F,max} = 5A, V_{R,max} = 600V,$<br>$P_{max} = 3.2 \text{ kW}, T_{vj,op} \leq T_{vj,op,max}$ |         |      |

<sup>1)</sup> depending on thermal properties of assembly
<sup>2)</sup> not subject to production test - verified by design/characterization

<sup>3)</sup> allowed number of short circuits: <1000; time between short circuits: >1s

| Parameter                            | Symbol               | Conditions   | Value |      |      | Unit |
|--------------------------------------|----------------------|--|-------|------|------|------|
|                                      | Symbol               | Conditions   | min.  | typ. | max. |      |
| Collector-Emitter breakdown voltage  | V <sub>(BR)CES</sub> | V <sub>GE</sub> =0V , <i>I</i> <sub>C</sub> = 0.2 mA | 600   |      |      |      |
| Collector-Emitter saturation voltage | V <sub>CEsat</sub>   | V <sub>GE</sub> =15V, <i>I</i> <sub>C</sub> =2.5A    |       | 1.65 | 2.1  |      |
| Diode Forward Voltage                | V <sub>F</sub>       | V <sub>GE</sub> =0V, I <sub>F</sub> =2.5A            |       | 1.7  | 2.1  | V    |
| Gate-Emitter threshold voltage       | V <sub>GE(th)</sub>  | $I_{\rm C}$ =0.05mA , $V_{\rm GE}$ = $V_{\rm CE}$    | 4.3   | 5    | 5.7  |      |
| Zero gate voltage collector current  | I <sub>CES</sub>     | $V_{CE}$ =600V , $V_{GE}$ =0V                        |       |      | 40   | μA   |
| Gate-Emitter leakage current         | I <sub>GES</sub>     | $V_{CE}=0V$ , $V_{GE}=20V$                           |       |      | 100  | nA   |
| Integrated gate resistor             | r <sub>G</sub>       |  |       | none |      | Ω    |

## Static Characteristics (tested on wafer), $T_{vj}$ =25 °C

Dynamic Characteristics (not subject to production test - verified by design / characterization), Tvj =25 °C

| Parameter                    | Symbol | Conditions        | Value |      |      | Unit |
|------------------------------|--------|-------------------|-------|------|------|------|
| Falameter                    | Symbol | Conditions        | min.  | typ. | max. | Unit |
| Input capacitance            | Cies   | $V_{CE}=25V$ ,    |       | 248  |      |      |
| Output capacitance           | Coes   | $V_{\rm GE}=0V$ , |       | 15   |      | pF   |
| Reverse transfer capacitance | Cres   | <i>f</i> =1MHz    |       | 7    |      |      |



## **Further Electrical Characteristic**

Switching characteristics and thermal properties are depending strongly on package design and mounting technology and can therefore not be specified for a bare die.

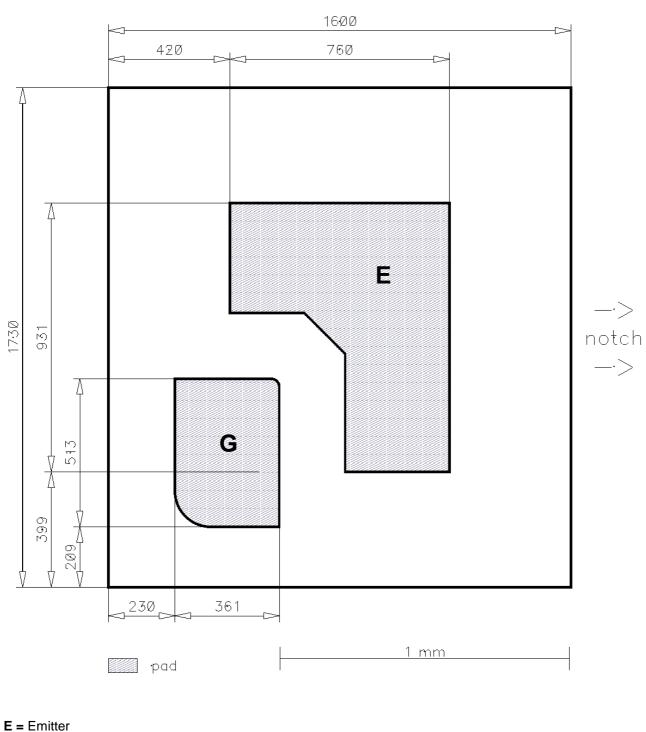
Further technical information about the performance of this chip in package t.b.d. is given exemplarily at www.infineon.com/igbt. The chip qualification is independent of the qualification which is performed for the Discretes.



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## **Chip Drawing**



Die−Size 1600 ·um x 1730 um

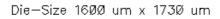
**G** = Gate

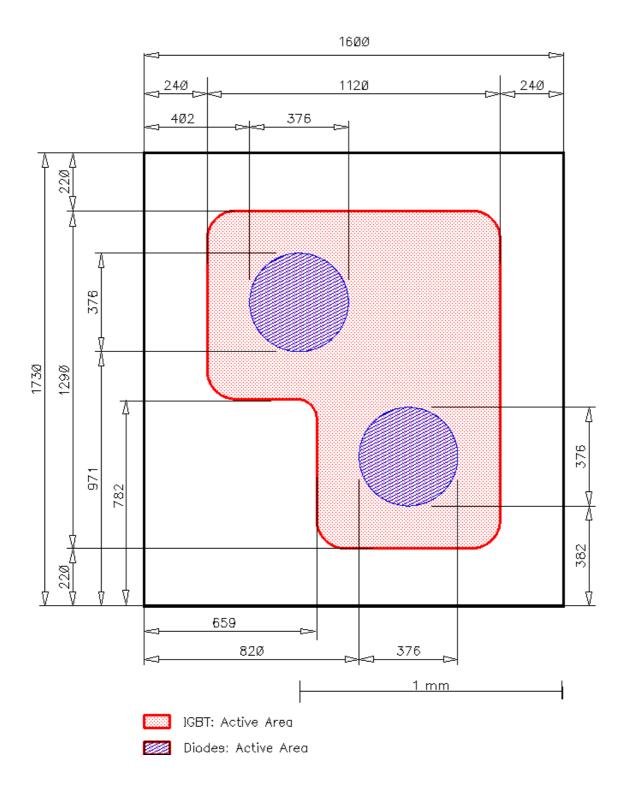


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# Chip Drawing active areas







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### Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

### **Revision History**

| Version | Subjects (major changes since last revision) | Date |
|---------|--|------|
|         |  |      |
|         |  |      |

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